Applicant(s)/Patent Under Application/Control No. Reexamination 09/110,667 BOYLAN III ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Son P. Huynh 2611 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY 725/41 US-6,239,794 05-2001 Yuen et al. Α * US-5,099,319 03-1992 Esch et al. 725/36 В US-С US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY N 0 Р Q R s Т

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